

P-Ch 20V Fast Switching MOSFETS

Product Summary

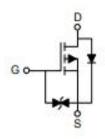
| BVDSS | RDSON | ID |
|-------|-------|-------|
| -20V | 420mΩ | -0.8A |

- Super Low Gate Charge
- Low Threshold
- High-Side Switching
- Advanced high cell density Trench technology

SOT523



Equivalent Circuit



Absolute Maximum Ratings

| Symbol | Parameter | Rating | Units |
|------------|--|------------|-------|
| Vos | Drain-Source Voltage | -20 | V |
| Vgs | Gate-Source Voltage | ±8 | V |
| Id@Ta=25°C | Continuous Drain Current, Vgs @ -4.5V1 | -0.8 | А |
| Ірм | Pulsed Drain Current ₂ | -2.4 | А |
| Pd@Ta=25°C | Total Power Dissipation3 | 0.35 | W |
| Тѕтс | Storage Temperature Range | -55 to 150 | °C |
| TJ | Operating Junction Temperature Range | -55 to 150 | °C |

Thermal Data

| Symbol | Parameter | Тур. | Max. | Unit |
|--------|---------------------------------------|------|------|------|
| Reja | Thermal Resistance Junction-Ambient 1 | | 357 | °C/W |



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit | |
|------------|--|--|-------------|--------|------|-------|--|
| BVpss | Drain-Source Breakdown Voltage | V _G s=0V , I _D =-250uA | - 20 | | | V | |
| △BVpss/△TJ | BV _{DSS} Temperature Coefficient | Reference to 25°C , I□=-1mA | | -0.014 | | V/°C | |
| D | | Vgs=-4.5V , Ip=-0.5A | | 420 | 500 | | |
| Rds(on) | Static Drain-Source On-Resistance2 | Vgs=-2.5V , Ip=-0.3A | | 550 | 680 | mΩ | |
| VGS(th) | Gate Threshold Voltage | Vgs=Vps . Ip =-250uA | -0.5 | -0.67 | -1.1 | V | |
| △VGS(th) | V _{GS(th)} Temperature Coefficient | VGS-VDS , ID250UA | | 3.95 | | mV/°C | |
| Ipss | Drain Source Leakage Current | V _{DS} =-16V , V _{GS} =0V , T _J =25°C | - | | -1 | | |
| IDSS | Drain-Source Leakage Current | V _{DS} =-16V , V _{GS} =0V , T _J =55°C | | | -5 | uA | |
| lgss | Gate-Source Leakage Current | Vgs=±10V, Vps=0V | 1 | | ±20 | nA | |
| Qg | | | 1 | 1 | - | nC | |
| Qgs | | V _{DS} =-10V , V _{GS} =-2.5V , I _D =-0.5A | 1 | 0.2 | | | |
| Qgd | Gate-Drain Charge | | - | 0.26 | | | |
| Td(on) | Turn-On Delay Time | | - | 9 | | | |
| Tr | Rise Time V_{DD} =-10V , Vgs=-4.5V , Rg=1 Ω | | | 10 | | ns | |
| Td(off) | Turn-Off Delay Time | I _D =-0.5A | | 10 | | 115 | |
| Tf | Fall Time | | - | 8 | | | |
| Ciss | Input Capacitance | V _{DS} =-10V , V _{GS} =0V , f=1MHz | | 45 | | | |
| Coss | Output Capacitance | | - | 15 | | pF | |
| Crss | Reverse Transfer Capacitance | | I | 10 | | | |

Diode Characteristics

| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit |
|--------|------------------------------------|---------------------------|------|------|------|------|
| VsD | Diode Forward Voltage ₂ | Vgs=0V , Is=-1A , TJ=25°C | | | -1.2 | ٧ |

Note:

- 1.The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width ≤ 300 us , duty cycle $\leq 2\%$
- 3.The power dissipation is limited by 150°C junction temperature
- 4. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



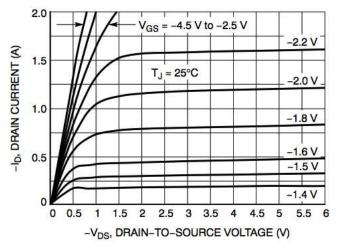


Figure 1. On-Region Characteristics

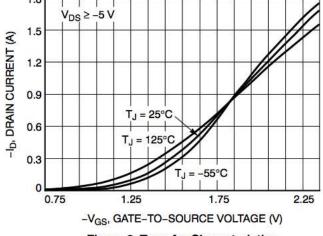


Figure 2. Transfer Characteristics

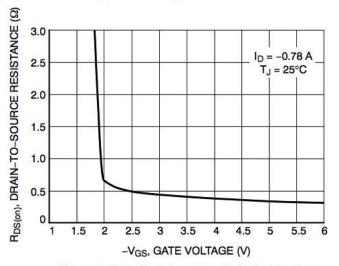


Figure 3. On-Resistance vs. Gate-to-Source Voltage

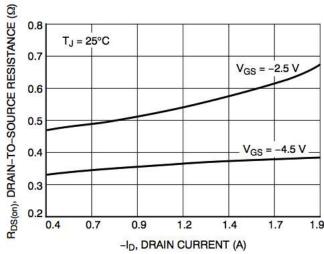


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

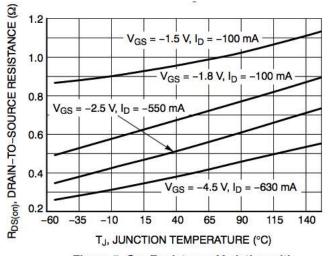


Figure 5. On–Resistance Variation with Temperature

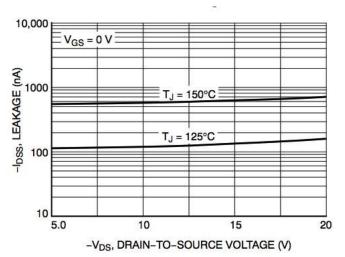
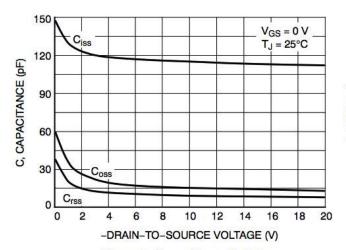


Figure 6. Drain-to-Source Leakage Current vs. Voltage





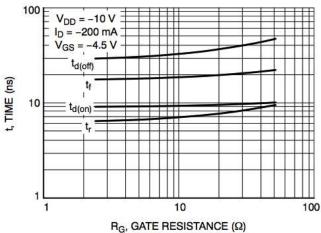


Figure 7. Capacitance Variation

Figure 8. Resistive Switching Time Variation vs. Gate Resistance

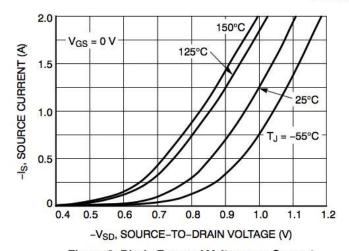
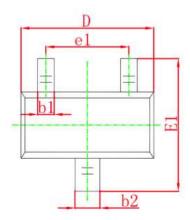
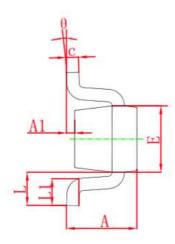


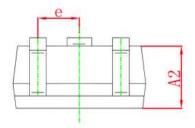
Figure 9. Diode Forward Voltage vs. Current



SOT523 Pin Configuration







| Combal | Dimensions In Millimeters | | Dimensions In Inches | |
|--------|---------------------------|-------|----------------------|-------|
| Symbol | Min. | Max. | Min. | Max. |
| Α | 0.700 | 0.900 | 0.028 | 0.035 |
| A1 | 0.000 | 0.100 | 0.000 | 0.004 |
| A2 | 0.700 | 0.800 | 0.028 | 0.031 |
| b1 | 0.150 | 0.250 | 0.006 | 0.010 |
| b2 | 0.250 | 0.350 | 0.010 | 0.014 |
| С | 0.100 | 0.200 | 0.004 | 0.008 |
| D | 1.500 | 1.700 | 0.059 | 0.067 |
| E | 0.700 | 0.900 | 0.028 | 0.035 |
| E1 | 1.450 | 1.750 | 0.057 | 0.069 |
| е | 0.500 TYP. | | 0.020 TYP. | |
| e1 | 0.900 | 1.100 | 0.035 | 0.043 |
| L | 0.400 REF. | | 0.016 REF. | |
| L1 | 0.260 | 0.460 | 0.010 | 0.018 |
| θ | 0° | 8° | 0° | 8° |

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